

Syllabus

Information of Course			
Career	Integrated master's/doctoral program (master's) [석박사통합과정]	Course Type	Elective(Graduate) [선택(석/박사)]
Course Number	34.696	System Number	MS696
Section		English	Korean
L:L:C(AU)	3:0:3.0(0)	Exam Hours (classroom)	
Course Title	Special Topic in Advanced Materials <Advanced Semiconductor Integrated Process Design> [신소재공학특론 <고급 반도체공정 설계>]		
Hours of instruction (classroom)	Wed: 15:00~18:00 / (W1)BLDG. of Applied Engineering [(W1)응용공학동] (2427)		
Notice			

Information of Professor		
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Plan of Lecture

Syllabus File

Syllabus URL

Summary of Lecture

The memory semiconductor process, device and design will be discussed from an industrial perspective. In the semiconductor processing, lithography, etch technology, diffusion technology, thin film technology, cleaning and CMP technology and flash process technology will be reviewed. In the device, DRAM technology and flash technology will be talked. Finally, in the design, DRAM design and flash design will be discussed.

Material for Teaching

- Main textbook : Hand out

- Auxiliary textbook :

References

1. Semiconductor Physics and Devices: Basic Principles, 3rd edition, Donald A. Neamen, McGraw-Hill
2. Semiconductor Device Fundamentals, Robert F. Pierret, Addison Wesley

Evaluation Criteria

Grading: 9% Homework, 45.5% Midterm, 45.5% Final Exam

Lecture Schedule

Week 1: Overview Memory Tech. Overview
 Week 2: Process Lithography Technology Process
 Week 3: Process Etch Technology
 Week 4: Process Diffusion Technology
 Week 5: Process Thin Film Technology
 Week 6: Process Cleaning & CMP Technology
 Week 7: Process Flash Process Technology
 Week 8: Midterm
 Week 9: Analysis Failure Analysis Technology
 Week 10: Device DRAM Technology
 Week 11: Device Flash Technology
 Week 12: Memory Test Memory Test Technology
 Week 13: Design DRAM Design
 Week 14: Design Flash Design
 Week 15: Packaging Packaging Technology
 Week 16: Final

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